Research Article

An Investigation of Nanocrystalline and Electrochemically Grown Cu$_2$ZnSnS$_4$ Thin Film Using Redox Couples of Different Band Offset

Prashant K. Sarswat, Michael L. Free, and Gagan Kumar

1 Department of Metallurgical engineering, University of UT, Salt Lake City, Utah 84112, USA
2 Institute for Research in Electronics and Applied Physics, University of Maryland, College Park, MD 20742, USA

Correspondence should be addressed to Prashant K. Sarswat; sarswatp@gmail.com

Received 31 May 2013; Accepted 12 August 2013

1. Introduction

In the last two decades, there has been significant interest in developing copper zinc tin sulfide, Cu$_2$ZnSnS$_4$ (CZTS) based solar cell devices. CZTS offers favorable optical and electronic properties suitable for solar cell applications. A tremendous improvement has been reported in the power conversion efficiency of CZTS device in the last few years [1]. Recently, 11.1% efficiency of photovoltaic device with standard configuration (glass/Mo/CZTS/Se/CdS/ZnO/ITO/Ni-Al) reported by IBM indeed proves that CZTS will be a leading candidate for thin film environmentally friendly solar cell [2]. One of the great advantages of this material is utilization of abundant and cost effective constituent elements. Despite the fact of improvement in efficiency, many other shortcomings are also needed to be overcome such as low fill factor, reduced short circuit current, and high recombination due to secondary phases. In all cases, it is essential to examine device performance prior to fabrication of complete photovoltaic cell. In most of the time photovoltaic properties of CZTS absorber were examined using a "semiconductor-electrolyte interface" as a testing analog [3]. This facilitates easy formation of Schottky barriers using heterojunctions [3]. A nondestructive way of photovoltaic property evaluation is an additional benefit. It can be seen that in many cases Eu$^{3+}$/Eu$^{2+}$ was utilized as a redox couple because of various associated advantages [3–5]. However, it is important to note that europium nitrate is a costly rare earth metal containing salt and strong oxidizer [6]. Hence, there is an urgent need to find alternative redox systems with properties of fast charge transfer and exhibiting photoelectrochemical behavior of CZTS absorber material. In this paper, we examine alternative electrolytes aiming to explore the enhanced photocurrent response in their respective applied potential range. We fabricate most of the CZTS thin films using electrodeposition-elevated temperature sulfurization on transparent conducting substrate. Some of the CZTS films are prepared using separately synthesized CZTS nanocrystals. The CZTS film qualities are finally evaluated for each
electrolyte system. It is important to mention that the fast developing area of plasmonics has great potential in enhancing the performance of the solar cells [7]. Plasmonics deals with the excitation of the surface plasmons which basically converts the light energy into electricity in the photovoltaic devices [8, 9]. Optical field enhancement in metallic nanostructures is generally utilized to achieve strong enhancement of optical absorption. Metallic nanoparticles or other dielectric nanocrystals support the energy collection of incident photons in surface plasmon oscillations. This energy can be subsequently transferred to the semiconductor substrate in a more efficient manner in comparison with the conventional photovoltaic CZTS absorber. These experiments and simulations are currently in progress. The present paper is organized as follow. In Section 2, we discuss the theory of the redox couple Cu2ZnSnS4 thin film band alignment. In Section 3, we discuss synthesis and characterization followed by results and discussion. The results are summarized in Section 5.

2. Theory

The important criterion for redox couple to be used for photoelectrochemical characterization of photovoltaic absorber layer is that, after reduction of one of the ionic species, it should not be deposited on the working electrode [3, 4]. Hence, many of the cost-effective redox couple cannot be used for this purpose due to electrodeposition. A schematic energy band alignment diagram (Figure 1) for CZTS has been drawn based on information from the literature [10, 11]. A Gaussian distribution of energy levels was assumed for oxidized and reduced species. It can be seen that conduction band offset for many redox species such as Fe(CN)63−/4−, Fe2+/Fe3+, and H2O/O2 is very high. Hence, they will not be a good choice to record photoelectrochemical response. In the contrary, conduction band offset for Eu3+/Eu2+ couple is relatively low. Moreover, that redox species is selected whose redox potential is in a range where no degradation of CZTS film occurs during electrochemical characterization [3, 4]. The standard electrode potential for Eu3+/Eu2+ is ∼–0.35 V (versus SHE) and it fulfills most of these requirements [3–5]. The schematic diagram shows only “estimated band position of CZTS” because exact values are not known due to ongoing research for this material. However, the species whose standard reduction potential is close to that of Eu3+/Eu2+ can be well chosen. The standard electrode potential values for selected redox reactions are shown in Table 1 [12, 13]: the Fe2+/Fe and Cd2+/Cd also have standard reduction potential value close to Eu3+/Eu2+, with very small

![Figure 1: A schematic diagram showing CZTS band alignment with different redox electrolytes.](https://example.com/figure1.png)

<table>
<thead>
<tr>
<th>No.</th>
<th>Electrode reaction</th>
<th>Standard reduction potential</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>HCHO(aq) + 2H2O + 2e− = CH3OH + 2OH−</td>
<td>−0.59 V</td>
</tr>
<tr>
<td>2</td>
<td>2CO2(g) + 2H+ + 2e− = HOOCCOOH(aq)</td>
<td>−0.49 V</td>
</tr>
<tr>
<td>3</td>
<td>Cr3+ + e− = Cr2+</td>
<td>−0.42 V</td>
</tr>
<tr>
<td>4</td>
<td>2SO42− + 3H2O + 4e− = S2O32− + 6OH−</td>
<td>−0.58 V</td>
</tr>
<tr>
<td>5</td>
<td>NO3− + H2O + e− = NO + 2OH−</td>
<td>−0.46 V</td>
</tr>
</tbody>
</table>
3. Experimental

3.1. Material. Copper sulfate pentahydrate, zinc sulfate hexahydrate, tin chloride, chromium(III) chloride, sodium sulfate, formaldehyde, hydrated europium nitrate, potassium ferricyanide, potassium ferrocyanide, and oxalic acid were purchased from M/s Sigma Aldrich. FTO coated glass substrate was purchased from M/s Pilkington USA. Ferricyanide, potassium ferrocyanide, and oxalic acid were utilized for photoelectrochemical study of CZTS films also utilized for reducing (99.999%), zinc(II) acetate (99.99%), tin(II) acetate anhydrous (∼97%), and thiourea (∼99%) were grinded homogeneously. The molar composition was chosen in such a manner so that stoichiometric ratio of Cu : Zn : Sn in mixture was ∼2:1:1. This mixture was sintered in the presence of evaporated sulfur environment for 2 hours at 550 °C. The annealing tube (alumina) was purged with argon for 150 min to displace air, prior to sulfurization. Elemental sulfur (99.9%), placed on quartz boat, was held at a temperature of 150°C as the sulfur source. In another experiment, sintering was carried out without sulfur. After 2 hours, natural cooling was allowed and material was examined for phase detection. A sponge-type soft material was obtained, which easily turns into powder when grinded. This powder was washed in KCN (10% by weight solution in water) solution followed by washing in 50% aqueous solution of isopropanol alcohol to remove residual sulfide phases. CZTS powder was dissolved in isopropanol and stirred for 3 hours. For better adhesion, 3% cellulose was also mixed after stirring. Few drops of terpineol were also added in the solution. These nanocrystals were coated on FTO substrate by immobilizing using 1,2-ethanedithiol linkers. Nanocrystals coated film was further annealed (temperature ∼300 °C) in an argon environment for duration of 1 hour. For method 2, an electrolyte containing ions of interest (Cu²⁺, Zn²⁺, and Sn²⁺) was used for growth of metallic layer [15, 18]. Coelectrodeposition was done by using 3-electrode cell connected to Gamry Instruments Reference 600 potentiostat operated by virtual front panel software. Electrodepositions were carried out at potential ∼1.6 V. Such films were annealed in evaporated sulfur environment to obtain CZTS thin film. A controlled sulfurization was carried out in a tube furnace to minimize film sheet resistance increment. Most of the sulfurized CZTS films were ∼1 μm thick. An inert atmosphere was maintained using continuous supply of argon. CZTS films were characterized by X-ray diffraction, Raman, and inductively coupled plasma optical emission spectroscopy to verify phase and purity. More details about CZTS film synthesis, characterizations (such as morphology, roughness, and optical properties) and diode parameters of CZTS film on various back contact can be found in earlier reports [15, 18, 19].

Due to fact that XRD pattern of CZTS is very similar to that of other possible sulfides, phase examination was carried out using Raman spectroscopy. An R 3000 QE Raman spectrometer (made by Raman Systems) was used for Raman spectroscopy. A laser excitation of wavelength ∼785 nm was used for Raman measurements. The laser power was ∼100 mW. Scanning electron microscopy was performed using an FEI Quanta 600TM scanning electron microscope. Band gap measurements of CZTS thin films were done using transmittance data obtained from an Ocean Optics spectrophotometer equipped with OOI Base 32 software [15, 18]. J-V curves were recorded during LED light illumination (incident illuminance on substrate ∼3.2 × 10⁴ lux at wavelength of ∼550 nm)) and in dark by using a Gamry Instruments Reference 600 potentiostat regulated by virtual front panel software. An equivalent concentration of all electrolytes solutions was ∼0.07 mole/l. In a typical experiment a CZTS coated thin film on FTO substrate was immersed in an aqueous solution of redox electrolyte together with a saturated calomel reference electrode (SCE) and a platinum counter electrode for measurements. The details of photoelectrochemical characterizations experiments can be found in earlier report [3]. 3D topographical images were captured by using an AmScope eyepiece camera equipped with TouView 3.2 software.

A flat band potential measurement was also carried out in order to estimate contribution from space charge current. Three-electrode electrochemical cell was used for flat band measurements. Mott-Schottky analysis was carried out for flat band potential evaluation. A substrate containing CZTS thin film grown on FTO substrate was immersed in various electrolytes. The following equation was used for flat band potential calculation [3]:

\[
\frac{1}{C_{sc}^2} = \frac{2}{\varepsilon_\varepsilon_0 N} \left[ (V - V_{fb}) - \frac{K_n T}{e} \right],
\]

where \(C_{sc}\) is capacitance of the depletion region and \(K_n\) is Boltzmann’s constant. The flat band potential was evaluated by extrapolation to \(1/C^2 = 0\) in the Mott-Schottky plot. "\(N\)" is the doping density, "\(e\)" represents electronic charge, "\(V\)" is applied potential, and "\(T\)" represents temperature. \(\varepsilon_\varepsilon_0\) is the dielectric constant of the semiconductor; \(\varepsilon_0\) is the permittivity of free space.
4. Results and Discussion

Figure 2 shows the Raman spectrum of the CZTS powder over the range from 200 to 400 cm\(^{-1}\). In the Raman spectrum an obvious major peak located at 336 cm\(^{-1}\) and two minor peaks at 368 cm\(^{-1}\) and 287 cm\(^{-1}\) can clearly be seen. This spectral data is in good agreement with the reported Raman spectra of CZTS [5]. SEM images of CZTS powder (on conducting substrate) and film surface are also shown in Figure 3. It can be seen that nanoparticles size is variable (Figure 3(a)). Few of them are less than 50 nm, while some of the particles are greater than 100 nm. Grains of CZTS film are \(\sim 1\) \(\mu\)m big, although we obtained some small-size particles (see Figure 3(b)).

The formation of conformal contact between CZTS and europium nitrate electrolyte promotes the minimization of minority carrier diffusion towards electrolyte [4]. For redox couples enlisted in Table 1, a similar phenomenon can be expected. Detailed discussion about photocurrent generation phenomenon during illumination can be found in earlier reports [3, 4]. For evaluation of photoelectrochemical performance, linear scan voltammograms were recorded by the potentiostat using virtual front panel software during flashing light illumination. The cathodic photocurrent response confirms p-type photoactivity of the annealed CZTS films. We examined both of our films (from nanocrystal suspension and electrochemically grown) for photoelectrochemical test, and we found that photocurrent for film grown by electrodeposition-sulfur annealing is relatively high. Small photocurrent response for nanocrystalline film can be attributed to high recombination and short lifetime of carrier. Hence, we conducted most of our experiments using film grown by method 2. We have evaluated change in current during illumination at different potential for different redox couples and average change in current during illumination is plotted in the same graph for comparison (see Figure 4). It can be seen that, for Cr\(^{3+}/Cr^{2+}\) redox couple, change in photocurrent (\(\Delta I\)) is maximum for small potential range (0 V to \(-0.5\) V). However, we were not able to characterize our film beyond this potential range due to its degradation.

On the other hand, all other proposed electrolytes showed photocurrent response up to potential 0.8 V. Specifically, both Eu\(^{3+}/Eu^{2+}\) redox couple and oxalic acid show significant change in photocurrent up to a potential of \(\sim 1\) volt. But it is interesting to note that maximum change in photocurrent using oxalic acid as an electrolyte was twice as high compared to europium nitrate electrolyte solution. Formaldehyde, sulfite, and nitrite couples also showed photoelectrochemical response, but change in photocurrent is approximately half compared to that with europium nitrate. It is essential to understand that enhanced cathodic photocurrent during illumination indicates an occurrence of reduction reaction. For oxalic acid case, it is possible due to presence of CO\(_2\) along with H\(^+\) in water. Although effects and actual content of dissolved CO\(_2\) in context of CZTS are not well studied, some reports discussed aspects of dissolved CO\(_2\) for other kind of wafers [20]. For this study, we have neglected dissolved CO\(_2\) contribution. Hence, it is very likely that cathodic photocurrent generation in this case is due to reduction of H\(^+\) into hydrogen gas. A separate comparative test was conducted using solution of sulfuric acid and oxalic acid with similar pH. It can be seen that photocurrent (Figure 5) is still high compared to that from sulfuric acid case. It illustrates that there are other additional operative mechanisms in case of oxalic acid aqueous solution which causes enhanced photovoltaic performance. This observation is encouraging and can be utilized as selective conversion of CO\(_2\) to oxalate in water.

In order to confirm whether alternative electrolytes can cause any phase change or degradation in CZTS absorber deposited on FTO, Raman spectroscopy was carried out. Figure 6 shows Raman spectra of a film (before and after electrochemical test) over the range from 250 to 400 cm\(^{-1}\). In all Raman spectra the two peaks are located at 336.5 and 367.5 cm\(^{-1}\) and it can be clearly seen that peak at \(\sim 336.5\) cm\(^{-1}\) is stronger peak. The Raman peak positions and relative intensities are in good agreement with the previously reported Raman spectra of CZTS thin film [5, 15]. No significant change in Raman spectra of film was observed after electrochemical test in sodium sulfite, formaldehyde, or sodium nitrite solution. After Lorentzian function fitting to both spectra, it was observed that both Raman linewidth and peak intensity did not change significantly which indicates that CZTS film’s phase integrity is not disrupted after photoelectrochemical examination in oxalic acid aqueous solution.

A comparison of film surface topography is shown in Figure 7. To evaluate larger film area, we used lower magnification images for analysis. A change in surface topography can be seen when the film is exposed to europium nitrate electrolyte solution. In an encircled area, one can observe some changes in film roughness. Thorough analysis suggests that less than \(\sim 20\%\) of film area was changed. However, there was more change in surface features and topography (\(\sim 45\%\) of film area) when electrochemical tests were run using oxalic acid electrolyte solution. For Cr\(^{3+}/Cr^{2+}\) redox couple, we observed huge change in surface topography (see Figure 8). Such films were not suitable for topography comparison after an electrochemical test. However, an optical image showing damaged portion of film is shown for comparison. Almost
no change in film topography was observed when photoelectrochemical tests were run using formaldehyde, sodium sulfate, and sodium nitrite solutions. An estimation of ionic species concentration, pH, and ionic strength was carried out using Visual MINTEQ software, in order to evaluate effects of these parameters. It was observed that oxalic acid, a strong acid, has lower pH value compared to that of europium nitrate aqueous solution. Hence, we can expect more change in surface topography in case of oxalic acid. Chromium chloride solution is also slightly acidic but acidity is less compared to oxalic acid solution. For sulfate and nitrite photoelectrochemical reaction causes creation of OH⁻ ion, still we did not observe any significant change in surface topography. A photocatalytic oxidation of SO₃²⁻ into S₂O₆²⁻ is reported [18], along with good amount of hydrogen production in the presence of mercury lamp. The kinetics of reported reaction is a multistage photolytic process and depends on several factors such as pH, concentration, temperature, and reaction pathways [21]. It is very likely that such mechanisms are operative; hence, we conducted a control test using a different copper working electrode. We did not observe any reportable change in photoactivity in this case. Hence, it can be said that most of the photoactivity is due to reduction of sulfate ion via CZTS-electrolyte charge transfer mechanism.

It can be seen that electrode reactions 1 and 4 (sulfite and formaldehyde) have shown higher photoelectrochemical response, whereas reaction 5 (nitrite) has relatively low photocurrent. Nitrite has good absorptivity in water; a broad
peak, centered at 355 nm corresponds to $n \rightarrow \pi^*$ transition [22]. At shorter wavelength it shows absorption due to $\pi \rightarrow \pi^*$ transition. Specifically for nitrite, photolysis process and species consumption/production involve a number of reactions; hence, it is difficult to measure individual rate of reaction. However, strong absorptivity in water can cause effective reduction of photons incident to CZTS film. We carried out a similar control test, what we conducted for sodium sulfite, and did not find any measurable contribution to total photoelectrochemical current. Despite the low photocurrent, it can be advantageous to use sodium nitrite because of its good corrosion inhibition properties [23].

The situation when defect states locate within center of the band gap can cause exchange of charge either from valence band or conduction band. There is a possibility that valance bandmediated charge transfer mechanism is operative and contributing to effective photoelectrochemical response. A separate experiment was conducted to investigate this phenomenon, where photoelectrochemical response of CZTS thin film was measured using Fe(CN)$_6^{3-/4-}$ redox couple. From Figure 1, it can be seen that Fe(CN)$_6^{3-/4-}$ redox couple is good choice, because its equivalent Fermi level lies very close to mid gap. Figure 9 shows the current potential behavior of CZTS working electrode immersed in Fe(CN)$_6^{3-/4-}$ during illumination and dark. It can be seen that there is not any good photocurrent response, indicating that most of the photoelectrochemical response in case of CZTS is due to conduction band-mediated charge transfer mechanism.

The total current is an aggregate of dark current, photocurrent, and space charge recombination current [3]. The photocurrent is a direct function of number of free electron in field free region (n). The value of “n” depends on many factors such as recombination rate, heterogeneous charge transfer rate, diffusion rate of electron, and intensity loss of photons during travel inside the solution. For similar substrate, incident power, and absorption coefficient of film, photocurrent contribution from each electrolyte was assumed to be same (light absorption in electrolyte was also assumed to be similar except for Cr$^{3+}$/Cr$^{2+}$). Contribution from space charge current ($J_{SCR}$) depends mainly on relative difference between flat band potential and applied voltage [3]:

$$J_{SCR} = B \sqrt{|(V_{fb} - V)|} e^{V/2K_BT}$$

(2)

where “B” is a recombination constant. The value of “B” depends on various factors including carrier thermal velocity, density of traps, and capture cross-section. For a similar value of “B,” the flat band potential will govern the change in $J_{SCR}$. It was observed that flat band potential for oxalic acid electrolyte is ~120 mV more than europium redox couple (see Figure 10). The lowest flat band potential was observed for sodium sulfite electrolyte. Altogether, it can be said that the square root term in (2) and subsequent space charge current will be different for these electrolytes. It was observed that such contribution or change is more effective towards anodic direction; however, most of our photoelectrochemical characterization was done at negative potential.

For large negative electrode potential, cathodic reaction at CZTS will be mainly due to transport control, and there will be significant loss of interfacial charge transfer control
Figure 7: 3D topography of CZTS film (area ∼50 µ× 50 µ). (a) Before electrochemical test in europium nitrate aqueous solution, (b) After electrochemical test in europium nitrate solution. (c) After electrochemical test in oxalic acid aqueous solution. (d) Before electrochemical test in formaldehyde aqueous solution. (e) After electrochemical test in formaldehyde aqueous solution. (f) After electrochemical test in sodium sulfite aqueous solution.

Figure 8: An optical micrograph of CZTS film after electrochemical test in chromium chloride solution; damaged film can be seen within encircled area.

Figure 9: Current potential behavior of CZTS thin film grown on FTO coated glass and immersed in redox electrolytes containing Fe(CN)$_6^{3-/4-}$ redox couple, during flashing light illumination.

Although majority of change in dark current beyond the standard reduction potential is due to reduction of one of the ionic species in solution [4], adsorption of species in electrode also causes change in rate kinetics [23]. It should be noted that most of the adsorbed species are different. The surface recombination rate constant is an important and highly sensitive parameter and it causes significant change in photocurrent when its value is changed twice of the original value [3]. Hence, it will be interesting to explore the effects of all these parameters as well as plasmonic effects [25] in detail; these experiments are in progress.
5. Conclusions

In summary, alternative electrolytes were examined to evaluate photoelectrochemical performance of CZTS absorber materials. Our primary results suggest that these electrolytes/redox couples can be beneficial due to equivalent or enhanced photocurrent response in their respective applied potential range. However, more details such as irreversibility and charge transfer process for these electrolytes are still needed to explore. In case of sodium sulfite and formaldehyde, photoelectrochemical response was satisfactory, whereas for sodium nitrite photocurrent was less. It was
observed that oxalic acid aqueous solution acts very well over the potential range of \(-0.5\) V to \(-1.0\) V. Film quality and topography were evaluated by comparing 3D topographical image and it was observed that oxalic acid redox couples cause less damage in surface features while for \(\text{Cr}^{3+}/\text{Cr}^{2+}\) redox couple film damage was high. Almost no damage was observed in CZTS thin film when sodium sulfite, formaldehyde, and sodium nitrite were used as redox scavenger. A difference in photocurrent for different electrolytes was explained on the basis of different defect states, adsorption of species in photoelectrode, and different surface recombination rate constant.

References
